

# **Excellent Integrated System Limited**

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Diodes Incorporated ZTX749STOA

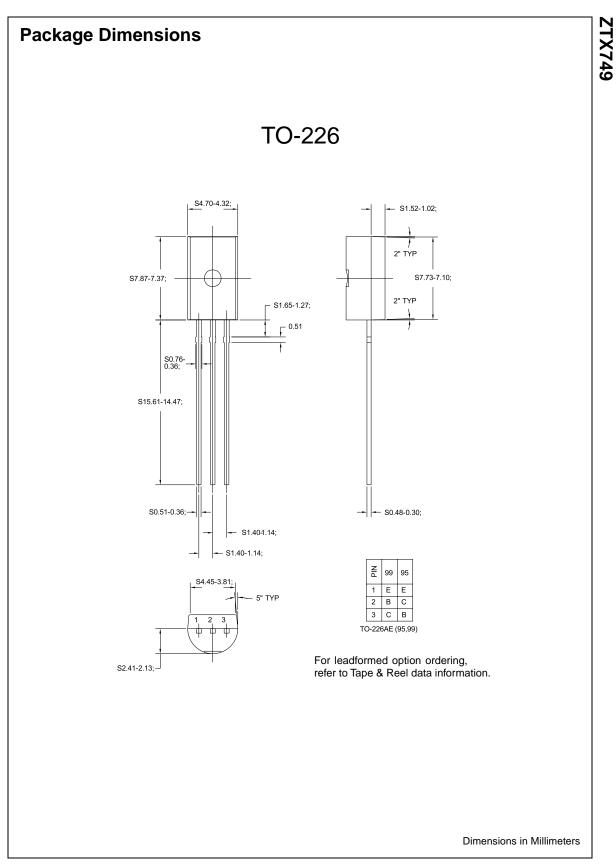
For any questions, you can email us directly: <u>sales@integrated-circuit.com</u>



	DNDUCTOR®						
	;	ZTX749					
This devi voltage w	w Saturation Transistor ce are designed with high current gain and vith collector currents up to 2A continuous.		C <sub>BE</sub>	тс	)-226		
Symb	te Maximum Ratings T <sub>A</sub> =25°C	C unless otherwise noted	Value		Un	nits	
-	Collector-Emitter Voltage			-25		V	
/ <sub>CEO</sub>	Collector-Base Voltage	5		-25 -35		V	
/ <sub>СВО</sub>	Emitter-Base Voltage		-35			V	
/ <sub>EBO</sub>	•	tinuous	-5			-	
<u>с</u>				0	A		
J, T <sub>STG</sub>	Operating and Storage Junction T are limiting values above which the serviceability of any		-55 ~ +15	iU .		°C	
lectric	spare based on a maximum junction temperature of 150° teady state limits. The factory should be consulted on ap cal Characteristics T <sub>A</sub> =25°C un	plications involving pulsed or lov			Max	Iheite	
<b>lectric</b> Symbol	teady state limits. The factory should be consulted on ap	plications involving pulsed or low		Min.	Max.	Units	
<b>lectric</b> Symbol Off Chara	teady state limits. The factory should be consulted on ap cal Characteristics T <sub>A</sub> =25°C un Parameter	plications involving pulsed or lov			Max.	Units	
<b>lectric</b> Symbol Off Chara	teady state limits. The factory should be consulted on ap <b>cal Characteristics</b> T <sub>A</sub> =25°C un Parameter Interistics	plications involving pulsed or lov less otherwise noted Test Conc		Min.	Max.		
<b>lectric</b> Symbol Off Chara BV <sub>CEO</sub> BV <sub>CBO</sub>	teady state limits. The factory should be consulted on ap <b>Cal Characteristics</b> T <sub>A</sub> =25°C un Parameter Interistics Collector-Emitter Breakdown Voltage	plications involving pulsed or low less otherwise noted $\hline I_{C} = -10mA$ $I_{C} = -100\mu A$ $I_{E} = -100\mu A$		<b>Min.</b> -25	Max.	V	
<b>lectric</b> Symbol Off Chara $3V_{CEO}$ $3V_{CBO}$ $3V_{CBO}$	teady state limits. The factory should be consulted on ap <b>Cal Characteristics</b> T <sub>A</sub> =25°C un <b>Parameter</b> <b>Interistics</b> Collector-Emitter Breakdown Voltage Collector-Base Breakdown Voltage	plications involving pulsed or low less otherwise noted Test Conc $I_C = -10mA$ $I_C = -100\mu A$	lition	Min. -25 -35	Max.	VV	
<b>lectric</b> Symbol Off Chara 3V <sub>CEO</sub> 3V <sub>CBO</sub> 3V <sub>EBO</sub> CBO	teady state limits. The factory should be consulted on ap <b>Cal Characteristics</b> T <sub>A</sub> =25°C un <b>Parameter</b> <b>Interistics</b> Collector-Emitter Breakdown Voltage Collector-Base Breakdown Voltage Emitter-Base Breakdown Voltage	plications involving pulsed or low less otherwise noted $\hline I_C = -10mA$ $I_C = -100\mu A$ $I_E = -100\mu A$ $V_{CB} = -30V$	lition	Min. -25 -35	-100	V V V nA	
<b>lectric</b> Symbol Off Chara 3V <sub>CEO</sub> 3V <sub>CBO</sub> 3V <sub>EBO</sub> CBO	teady state limits. The factory should be consulted on ap Cal Characteristics T <sub>A</sub> =25°C un Parameter Interistics Collector-Emitter Breakdown Voltage Collector-Base Breakdown Voltage Emitter-Base Breakdown Voltage Collector Cutoff Current	plications involving pulsed or low less otherwise noted $\hline I_C = -10mA$ $I_C = -100\mu A$ $I_E = -100\mu A$ $V_{CB} = -30V$ $V_{CB} = -30V, T_A = 10$ $V_{EB} = -4V$	lition 0°C	Min. -25 -35	-100 -10	V V V nA μA	
<b>lectric</b> Symbol Off Chara $3V_{CEO}$ $3V_{CBO}$ $3V_{EBO}$ CBO EBO Dn Chara	teady state limits. The factory should be consulted on ap Cal Characteristics T <sub>A</sub> =25°C un Parameter Interistics Collector-Emitter Breakdown Voltage Collector-Base Breakdown Voltage Emitter-Base Breakdown Voltage Collector Cutoff Current Emitter Cutoff Current	plications involving pulsed or low less otherwise noted $\hline I_C = -10mA$ $I_C = -100\mu A$ $I_E = -100\mu A$ $V_{CB} = -30V$ $V_{CB} = -30V, T_A = 10$ $V_{EB} = -4V$ $\hline I_C = -50mA, V_{CE} = -2V$ $I_C = -1A, V_{CE} = -2V$ $I_C = -2A, V_{CE} = -2V$	lition 0°C	Min. -25 -35	-100 -10	V V V nA μA	
<b>lectric</b> Symbol Off Chara 3V <sub>CEO</sub> 3V <sub>CBO</sub> 3V <sub>EBO</sub> CBO EBO Dn Chara	teady state limits. The factory should be consulted on ap <b>Cal Characteristics</b> T <sub>A</sub> =25°C un Parameter Interistics Collector-Emitter Breakdown Voltage Collector-Base Breakdown Voltage Emitter-Base Breakdown Voltage Collector Cutoff Current Emitter Cutoff Current Emitter Cutoff Current	$\begin{tabular}{ l l l l l l l l l l l l l l l l l l l$	lition 0°C 2V A A	Min. -25 -35 -5 -5 70 100 75	-100 -10 -100	V V V nA μA	
<b>lectric</b> Symbol Off Chara 3V <sub>CEO</sub> 3V <sub>CBO</sub> 3V <sub>EBO</sub> CBO EBO Dn Chara	teady state limits. The factory should be consulted on ap Cal Characteristics T <sub>A</sub> =25°C un Parameter Interistics Collector-Emitter Breakdown Voltage Collector-Base Breakdown Voltage Emitter-Base Breakdown Voltage Collector Cutoff Current Emitter Cutoff Current Ceristics* DC Current Gain	$\begin{tabular}{ l l l l l l l l l l l l l l l l l l l$	lition 0°C 2V A A	Min. -25 -35 -5 -5 70 100 75	-100 -10 -100 -100 -100 -300	V V V nA μA nA	
Iectric Symbol Off Chara 3V <sub>CEO</sub> 3V <sub>CBO</sub> 3V <sub>EBO</sub> CBO EBO Dn Chara <sup>h</sup> FE	teady state limits. The factory should be consulted on ap Cal Characteristics T <sub>A</sub> =25°C un Parameter Interistics Collector-Emitter Breakdown Voltage Collector-Base Breakdown Voltage Collector Cutoff Current Emitter Cutoff Current Cteristics* DC Current Gain Collector-Emitter Saturation Voltage	$\begin{tabular}{ l l l l l l l l l l l l l l l l l l l$	lition 0°C 2V A A	Min. -25 -35 -5 -5 70 100 75	-100 -10 -100 -100 -300 -300 -500	V V ν nA μA nA	
Iectric Symbol Off Chara 3V <sub>CEO</sub> 3V <sub>CBO</sub> 3V <sub>EBO</sub> CBO EBO Dn Chara PFE / <sub>CE</sub> (sat) / <sub>BE</sub> (sat) / <sub>BE</sub> (on) Small-Sig	teady state limits. The factory should be consulted on ap Cal Characteristics T <sub>A</sub> =25°C un Parameter Interistics Collector-Emitter Breakdown Voltage Collector-Base Breakdown Voltage Emitter-Base Breakdown Voltage Collector Cutoff Current Emitter Cutoff Current Cteristics* DC Current Gain Collector-Emitter Saturation Voltage Base-Emitter Saturation Voltage	$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	lition 0°C 2V A A A	Min. -25 -35 -5 -5 70 100 75	-100 -10 -100 -100 -300 -500 -1.25	V V ν nA μA nA mV	
Iectric Symbol Off Chara 3V <sub>CEO</sub> 3V <sub>CBO</sub> 3V <sub>EBO</sub> CBO EBO Dn Chara PFE / <sub>CE</sub> (sat) / <sub>BE</sub> (sat) / <sub>BE</sub> (on) Small-Sig	teady state limits. The factory should be consulted on ap Cal Characteristics T <sub>A</sub> =25°C un Parameter Interistics Collector-Emitter Breakdown Voltage Collector-Base Breakdown Voltage Emitter-Base Breakdown Voltage Collector Cutoff Current Emitter Cutoff Current Cteristics* DC Current Gain Collector-Emitter Saturation Voltage Base-Emitter Saturation Voltage Base-Emitter On Voltage Inal Characteristics Output Capacitance	$\label{eq:linear_product} \begin{array}{c} \mbox{Ications involving pulsed or low} \\ \hline \mbox{Ics otherwise noted} \\ \hline \mbox{Ics otherwise noted} \\ \hline \mbox{Ics -100} \mu A \\ \hline \mbox{Ic} = -100 \mu A \\ \hline \mbox{Ic} = -30V \\ \hline \mbox{V}_{CB} = -4V \\ \hline \mbox{Ic} = -1A, \ \mbox{V}_{CE} = -2V \\ \hline \mbox{Ic} = -2A, \ \mbox{V}_{CE} = -2V \\ \hline \mbox{Ic} = -1A, \ \mbox{Ic} = -2V \\ \hline \mbox{Ic} = -1A, \ \mbox{Ig} = -100m \\ \hline \mbox{Ic} = -1A, \ \mbox{V}_{CE} = -2V \\ \hline \mbox{Ic} = -1A, \ \mbox{V}_{CE} = -2V \\ \hline \mbox{V}_{CB} = -10V, \ \mbox{Ic} = 0, \ \mbox{f} \end{array}$	lition 0°C 2V A A A = 1MHz	Min. -25 -35 -5 -5 70 100 75	-100 -10 -100 -100 -300 -500 -1.25	V V ν nA μA nA mV	
Iectric Symbol Off Chara 3V <sub>CEO</sub> 3V <sub>CBO</sub> 3V <sub>EBO</sub> CBO EBO Dn Chara PFE /CE(Sat) /BE(on) Small-Sig Cobo	teady state limits. The factory should be consulted on ap Cal Characteristics T <sub>A</sub> =25°C un Parameter Interistics Collector-Emitter Breakdown Voltage Collector-Base Breakdown Voltage Emitter-Base Breakdown Voltage Collector Cutoff Current Emitter Cutoff Current Cteristics* DC Current Gain Collector-Emitter Saturation Voltage Base-Emitter Saturation Voltage Base-Emitter On Voltage Inal Characteristics Output Capacitance Transition Frequency	$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	lition 0°C 2V A A A = 1MHz	Min. -25 -35 -5 -5 70 100 75	-100 -10 -10 -100 -100 -300 -500 -1.25 -1	V V nA μA nA mV V V	
Iectric Symbol Off Chara 3V <sub>CEO</sub> 3V <sub>CBO</sub> CBO CBO EBO Dn Chara FE /CE(Sat) /B(Sat) /B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sa	teady state limits. The factory should be consulted on ap Cal Characteristics T <sub>A</sub> =25°C un Parameter Cteristics Collector-Emitter Breakdown Voltage Collector-Base Breakdown Voltage Collector Cutoff Current Emitter Cutoff Current Cteristics* DC Current Gain Collector-Emitter Saturation Voltage Base-Emitter Saturation Voltage Base-Emitter On Voltage mal Characteristics Output Capacitance Transition Frequency ulse Width ≤ 300µs, Duty Cycle ≤ 2%	$\begin{tabular}{ c  } \hline Plications involving pulsed or low less otherwise noted \\ \hline Test Conc \\ \hline I_C = -100 \mu A \\ \hline I_C = -100 \mu A \\ \hline I_E = -100 \mu A \\ \hline V_{CB} = -30V \\ \hline V_{CB} = -4V \\ \hline I_C = -100 \mu A \\ \hline I_C = -100 \mu A \\ \hline I_C = -2A, V_{CE} = -2V \\ \hline I_C = -2A, V_{CE} = -2V \\ \hline I_C = -1A, I_B = -100m \\ \hline I_C = -1A, I_B = -100m \\ \hline I_C = -1A, I_B = -100m \\ \hline I_C = -1A, V_{CE} = -2V \\ \hline V_{CB} = -10V, I_E = 0, f \\ \hline I_C = 100MHz \\ \hline \end{tabular}$	lition 0°C 2V A A A = 1MHz	Min. -25 -35 -5 70 100 75 15	-100 -10 -10 -100 -100 -300 -500 -1.25 -1	V V nA μA nA mV V V	
Iectric Symbol Off Chara 3VCEO 3VCBO 3VCBO CBO CBO CBO Dn Chara DFE /CE(Sat) /BE(Sat)/BE(Sat)/BE(Sat)/BE(Sat)/BE(Sat)/BE(Sat)/BE(Sat)/BE(S	teady state limits. The factory should be consulted on ap Cal Characteristics T <sub>A</sub> =25°C un Parameter Ceteristics Collector-Emitter Breakdown Voltage Collector-Base Breakdown Voltage Collector Cutoff Current Emitter Cutoff Current Emitter Cutoff Current Ceteristics* DC Current Gain Collector-Emitter Saturation Voltage Base-Emitter On Voltage Base-Emitter On Voltage Transition Frequency Use Width ≤ 300µs, Duty Cycle ≤ 2% Collector T <sub>A</sub> =25°C unles	$\begin{tabular}{ c  } \hline Plications involving pulsed or low less otherwise noted \\ \hline Test Conc \\ \hline I_C = -100 \mu A \\ \hline I_C = -100 \mu A \\ \hline I_E = -100 \mu A \\ \hline V_{CB} = -30V \\ \hline V_{CB} = -4V \\ \hline I_C = -100 \mu A \\ \hline I_C = -100 \mu A \\ \hline I_C = -2A, V_{CE} = -2V \\ \hline I_C = -2A, V_{CE} = -2V \\ \hline I_C = -1A, I_B = -100m \\ \hline I_C = -1A, I_B = -100m \\ \hline I_C = -1A, I_B = -100m \\ \hline I_C = -1A, V_{CE} = -2V \\ \hline V_{CB} = -10V, I_E = 0, f \\ \hline I_C = 100MHz \\ \hline \end{tabular}$	lition 0°C 2V A A A = 1MHz	Min. -25 -35 -5 70 100 75 15	-100 -10 -100 -100 -100 -300 -300 -300 -	V V nA μA nA mV V V	
Iectric Symbol Off Chara 3V <sub>CEO</sub> 3V <sub>CBO</sub> CBO CBO EBO Dn Chara FE /CE(Sat) /B(Sat) /B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sat)/B(Sa	teady state limits. The factory should be consulted on ap Cal Characteristics T <sub>A</sub> =25°C un Parameter Ceteristics Collector-Emitter Breakdown Voltage Collector-Base Breakdown Voltage Collector Cutoff Current Emitter Cutoff Current Emitter Cutoff Current Ceteristics* DC Current Gain Collector-Emitter Saturation Voltage Base-Emitter On Voltage Base-Emitter On Voltage Transition Frequency Use Width ≤ 300µs, Duty Cycle ≤ 2% Collector T <sub>A</sub> =25°C unles	plications involving pulsed or low less otherwise noted $\hline I_C = -10mA \\ I_C = -100\muA \\ I_E = -100\muA \\ V_{CB} = -30V \\ V_{CB} = -30V, T_A = 10 \\ V_{EB} = -4V \\ \hline I_C = -50mA, V_{CE} = -2V \\ I_C = -1A, V_{CE} = -2V \\ I_C = -2A, V_{CE} = -2V \\ I_C = -6A, V_{CE} = -2V \\ I_C = -1A, I_B = -100m, I_C = -2A, I_B = -200m, I_C = -1A, I_B = -100m, I_C = -1A, V_{CE} = -2V \\ \hline V_{CB} = -10V, I_E = 0, f \\ I_C = 1-00mA, V_{CE} = f = 100MHz \\ \hline \end{tabular}$	lition 0°C 2V A A A = 1MHz	Min. -25 -35 -5 -5 70 100 75 15 100 100	-100 -10 -100 -100 -100 -300 -500 -1.25 -1 100	V V nA μA nA mV V V	

ZTX749





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## PRODUCT STATUS DEFINITIONS

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